

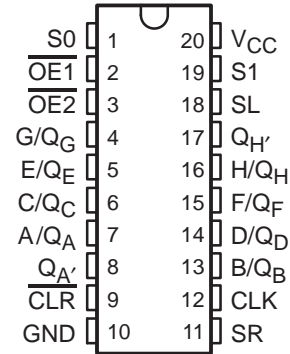
SN74F323

8-BIT UNIVERSAL SHIFT-STORAGE REGISTER WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS

SDFS072A – D2932, MARCH 1987 – REVISED OCTOBER 1993

- **Four Modes of Operation:**
 - Hold (Store)
 - Shift Right
 - Shift Left
 - Load Data
- **Operates With Outputs Enabled or at High Impedance**
- **3-State Outputs Drive Bus Lines Directly**
- **Can Be Cascaded for N-Bit Word Lengths**
- **Synchronous Clear**
- **Applications:**
 - Stacked or Push-Down Registers
 - Buffer Storage
 - Accumulator Registers
- **Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs**

**DW OR N PACKAGE
(TOP VIEW)**



description

This 8-bit universal register features multiplexed I/O ports to achieve full 8-bit data handling in a single 20-pin package. Two function-select (S0, S1) and two output-enable ($\overline{OE1}$, $\overline{OE2}$) inputs can be used to choose the modes of operation listed in the function table.

Synchronous parallel loading is accomplished by taking both S0 and S1 high. This places the 3-state outputs in a high-impedance state and permits data that is applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs synchronously when the clear (\overline{CLR}) input is low. Taking either $\overline{OE1}$ or $\overline{OE2}$ high disables the outputs but this has no effect on clearing, shifting, or storage of data.

The SN74F323 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE

MODE	INPUTS							I/O PORTS								OUTPUTS		
	$\overline{\text{CLR}}$	S1	S0	$\overline{\text{OE1}}^\dagger$	$\overline{\text{OE2}}^\dagger$	CLK	SL	SR	A/Q _A	B/Q _B	C/Q _C	D/Q _D	E/Q _E	F/Q _F	G/Q _G	H/Q _H	Q _A '	Q _H '
Clear	L	X	L	L	L	\uparrow	X	X	L	L	L	L	L	L	L	L	L	L
	L	L	X	L	L	\uparrow	X	X	L	L	L	L	L	L	L	L	L	L
	L	H	H	X	X	\uparrow	X	X	X	X	X	X	X	X	X	X	L	L
Hold	H	L	L	L	L	X	X	X	Q _{A0}	Q _{B0}	Q _{C0}	Q _{D0}	Q _{E0}	Q _{F0}	Q _{G0}	Q _{H0}	Q _{A0}	Q _{H0}
	H	X	X	L	L	L	X	X	Q _{A0}	Q _{B0}	Q _{C0}	Q _{D0}	Q _{E0}	Q _{F0}	Q _{G0}	Q _{H0}	Q _{A0}	Q _{H0}
Shift Right	H	L	H	L	L	\uparrow	X	H	H	Q _{An}	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	Q _{Gn}	H	Q _{Gn}
	H	L	H	L	L	\uparrow	X	L	L	Q _{An}	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	Q _{Gn}	L	Q _{Gn}
Shift Left	H	H	L	L	L	\uparrow	H	X	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	Q _{Gn}	Q _{Hn}	H	Q _{Bn}	H
	H	H	L	L	L	\uparrow	L	X	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	Q _{Gn}	Q _{Hn}	L	Q _{Bn}	L
Load	H	H	H	X	X	\uparrow	X	X	a	b	c	d	e	f	g	h	a	h

NOTE: a . . . h = the level of the steady-state input at inputs A through H, respectively. These data inputs are loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.

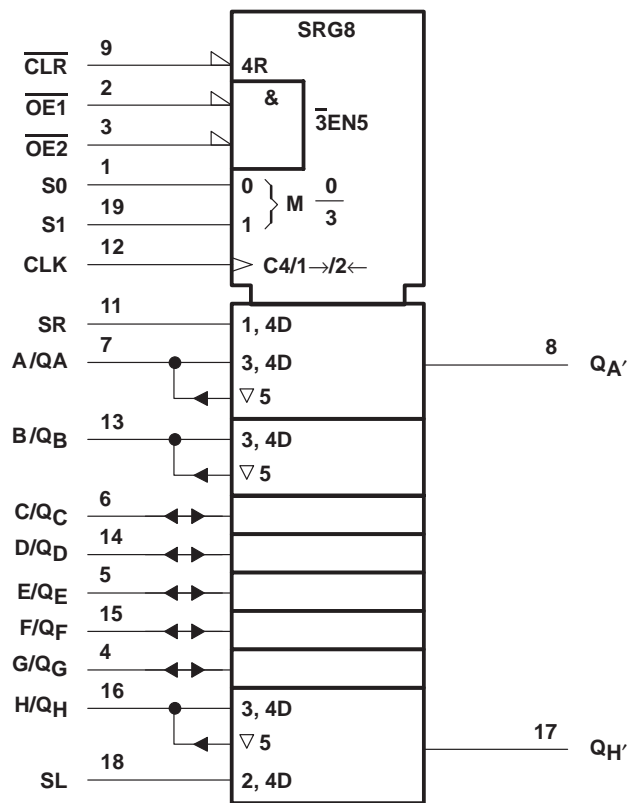
† When one or both output-enable inputs are high the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

SN74F323

8-BIT UNIVERSAL SHIFT-STORAGE REGISTER WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS

SDFS072A – D2932, MARCH 1987 – REVISED OCTOBER 1993

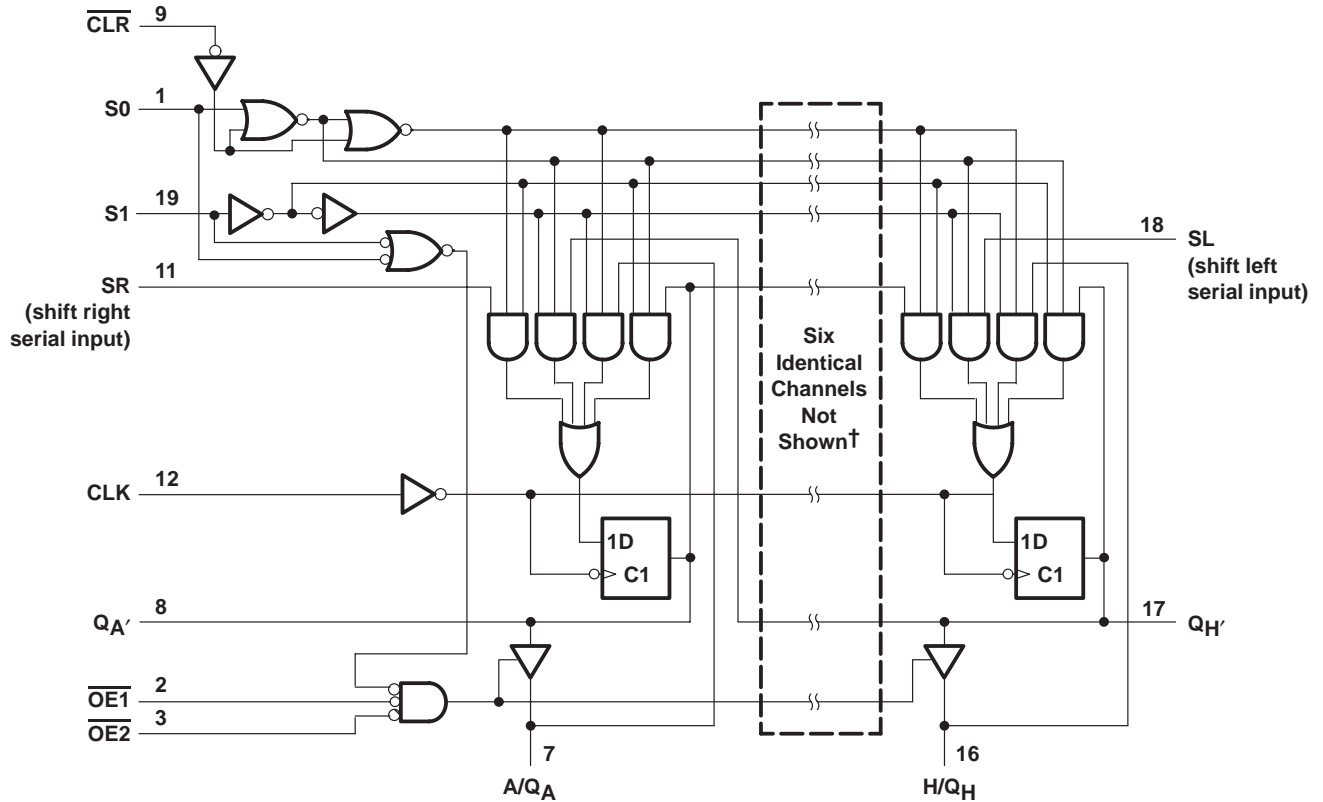
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SN74F323
8-BIT UNIVERSAL SHIFT-STORAGE REGISTER
WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS
SDFS072A – D2932, MARCH 1987 – REVISED OCTOBER 1993

logic diagram (positive logic)



† I/O ports not shown: B/Q_B (13), C/Q_C (6), D/Q_D (14), E/Q_E (5), F/Q_F (15), and G/Q_G (4).

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–1.2 V to 7 V
Input current range	–30 mA to 5 mA
Voltage range applied to any output in the disabled or power-off state	–0.5 V to 5.5 V
Voltage range applied to any output in the high state	–0.5 V to V_{CC}
Current into any output in the low state: $Q_{A'}$ or $Q_{H'}$	40 mA
Q_A thru Q_H	48 mA
Operating free-air temperature range	0°C to 70°C
Storage temperature range	–65°C to 150°C

‡ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

SN74F323

8-BIT UNIVERSAL SHIFT-STORAGE REGISTER

WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS

SDFS072A – D2932, MARCH 1987 – REVISED OCTOBER 1993

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
I_{IK}	Input clamp current			–18	mA
I_{OH}	High-level output current			Q_A' or Q_H'	–1
				Q_A thru Q_H	–3
I_{OL}	Low-level output current			Q_A' or Q_H'	20
				Q_A thru Q_H	24
T_A	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}		$V_{CC} = 4.5$ V,	$I_I = -18$ mA			–1.2	V
V_{OH}	Q_A' or Q_H'	$V_{CC} = 4.5$ V	$I_{OH} = -1$ mA	2.5	3.4		V
	Q_A thru Q_H		$I_{OH} = -1$ mA	2.5	3.4		
			$I_{OH} = -3$ mA	2.4	3.3		
	Any output	$V_{CC} = 4.75$ V,	$I_{OH} = -1$ mA to -3 mA	2.7			
V_{OL}	Q_A' or Q_H'	$V_{CC} = 4.5$ V	$I_{OL} = 20$ mA		0.3	0.5	V
	Q_A thru Q_H		$I_{OL} = 24$ mA		0.35	0.5	
I_I	A thru H	$V_{CC} = 5.5$ V	$V_I = 5.5$ V			1	mA
	Any other		$V_I = 7$ V			0.1	
I_{IH}^\ddagger	A thru H	$V_{CC} = 5.5$ V,	$V_I = 2.7$ V			70	μ A
	Any other					20	
I_{IL}^\ddagger	A thru H	$V_{CC} = 5.5$ V,	$V_I = 0.5$ V			–0.65	mA
	S0 or S1					–1.2	
	Any other					–0.6	
I_{OS}^\S		$V_{CC} = 5.5$ V,	$V_O = 0$	–60		–150	mA
I_{CC}		$V_{CC} = 5.5$ V,	See Note 2		68	95	mA

† All typical values are at $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$.

‡ For I/O ports (Q_A thru Q_H), the parameters I_{IH} and I_{IL} include the off-state output current.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: I_{CC} is measured with $\overline{OE}1$, $\overline{OE}2$, and CLK at 4.5 V.

SN74F323

8-BIT UNIVERSAL SHIFT-STORAGE REGISTER WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS

SDFS072A – D2932, MARCH 1987 – REVISED OCTOBER 1993

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

			V _{CC} = 5 V, T _A = 25°C		MIN	MAX	UNIT
			MIN	MAX			
f _{clock}	Clock frequency		0	70	0	70	MHz
t _w	Pulse duration	CLK high or low	7		7		ns
t _{su}	Setup time before CLK↑	S0 or S1	High or low	8.5	8.5		ns
		A/Q _A thru H/Q _H , SR, or SL	High or low	5	5		
		CLR	High or low	10	10		
t _h	Hold time after CLK↑	S0 or S1	High or low	0	0		ns
		A/Q _A thru H/Q _H , SR, or SL	High or low	2	2		
		CLR	High or low	0	0		

switching characteristics (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, C _L = 50 pF, R _L = 500 Ω, T _A = 25°C			V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R _L = 500 Ω, T _A = MIN to MAX†		UNIT
			MIN	TYP	MAX	MIN	MAX	
f _{max}			70	100		70		MHz
t _{PLH}	CLK	Q _A ' or Q _H '	3.2	6.6	9	3.2	10	ns
t _{PHL}			2.7	6.1	8.5	2.7	9.5	
t _{PLH}	CLK	Q _A thru Q _H	3.2	6.6	9	3.2	10	ns
t _{PHL}			4.2	8.1	11	4.2	12	
t _{PZH}	$\overline{OE1}$ or $\overline{OE2}$	Q _A thru Q _H	2.7	5.6	8	2.7	9	ns
t _{PZL}			3.2	6.6	10	3.2	11	
t _{PHZ}	$\overline{OE1}$ or $\overline{OE2}$	Q _A thru Q _H	1.7	4.1	6	1.7	7	ns
t _{PLZ}			1.2	3.6	5.5	1.2	6.5	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 3: Load circuits and waveforms are shown in Section 1.

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.